

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit	1797	Page 1 of 1
Lucas Stelling				

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	U	Derwent abstract for JP 01-01094997, Fujino K, 1989.
	V	Derwent abstract for JP 2002086155, Nakamura K; 2002.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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